### **LG T676**

#### **TOPLED®**

TOPLED, SMT LED with integrated reflector. With our great experience in SMT LED we are able to offer a high quality product for all kind of applications.









### **Applications**

- Cluster, Button Backlighting
- Electronic Equipment

- Interior Illumination e.g. Ambient Map
- White Goods

### Features:

- Package: white PLCC-2 package, colorless clear resin

- Chip technology: InGaAIP

- Typ. Radiation: 120° (Lambertian emitter)

− Color:  $λ_{dom}$  = 570 nm (• green)

- Corrosion Robustness Class: 3B

- ESD: 2 kV acc. to ANSI/ESDA/JEDEC JS-001 (HBM)



Ordering Information									
Туре	Luminous Intensity 1)  I <sub>F</sub> = 20 mA I <sub>v</sub>	Ordering Code							
LG T676-P1Q2-24	45 112 mcd	Q65110A2178							
LG T676-P2R1-24	56 140 mcd	Q65110A4007							



### LG T676

Maximum Ratings			
Parameter	Symbol		Values
Operating Temperature	T <sub>op</sub>	min. max.	-40 °C 100 °C
Storage Temperature	$T_{stg}$	min. max.	-40 °C 100 °C
Junction Temperature	$T_{j}$	max.	125 °C
Forward current T <sub>S</sub> = 25 °C	I <sub>F</sub>	max.	30 mA
Surge Current t $\leq$ 10 µs; D = 0.005 ; T <sub>s</sub> = 25 °C	I <sub>FS</sub>	max.	1000 mA
Reverse voltage <sup>2)</sup> T <sub>S</sub> = 25 °C	$V_R$	max.	12 V
ESD withstand voltage acc. to ANSI/ESDA/JEDEC JS-001 (HBM)	$V_{ESD}$		2 kV



## **Characteristics**

 $I_F = 20$  mA;  $T_S = 25$  °C

Parameter	Symbol	Values	
Peak Wavelength	$\lambda_{peak}$	typ.	572 nm
Dominant Wavelength 3)	$\lambda_{\sf dom}$	min.	566 nm
$I_F = 20 \text{ mA}$	dom	typ.	570 nm
		max.	575 nm
Viewing angle at 50 % I <sub>V</sub>	2φ	typ.	120 °
Forward Voltage 4)	$V_{F}$	min.	1.80 V
$I_F = 20 \text{ mA}$		typ.	2.00 V
		max.	2.40 V
Reverse current 2)	I <sub>R</sub>	typ.	0.01 μΑ
V <sub>R</sub> = 12 V		max.	10 μΑ
Temperature Coefficient of Peak Wavelength -10°C ≤ T ≤ 100°C	$TC_{\lambda peak}$	typ.	0.12 nm / K
Temperature Coefficient of Forward Voltage -10°C ≤ T ≤ 100°C	$TC_{VF}$	typ.	-2.6 mV / K
Real thermal resistance junction/ambient 5), 6)	R <sub>thJA real</sub>	max.	500 K / W
Real thermal resistance junction/solderpoint 5)	R <sub>thJS real</sub>	max.	280 K / W



# **Brightness Groups**

Group	Luminous Intensity <sup>1)</sup> I <sub>F</sub> = 20 mA min. I <sub>v</sub>	Luminous Intensity. 1)  I <sub>F</sub> = 20 mA  max. I <sub>v</sub>	Luminous Flux <sup>7)</sup> $I_F = 20 \text{ mA}$ typ. $\Phi_V$
P1	45 mcd	56 mcd	150 mlm
P2	56 mcd	71 mcd	190 mlm
Q1	71 mcd	90 mcd	240 mlm
Q2	90 mcd	112 mcd	300 mlm
R1	112 mcd	140 mcd	380 mlm

# Wavelength Groups

Group	Dominant Wavelength <sup>3)</sup> I <sub>F</sub> = 20 mA	Dominant Wavelength <sup>3)</sup> I <sub>F</sub> = 20 mA		
	min.	max.		
	$\lambda_{dom}$	$\lambda_{dom}$		
2	566 nm	569 nm		
3	569 nm	572 nm		
4	572 nm	575 nm		

# **Group Name on Label**

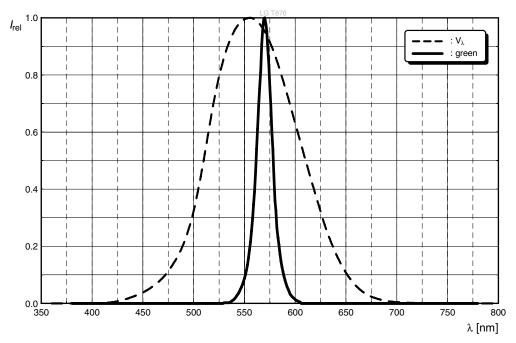
Example: P1-2

Brightness Wavelength
P1 2



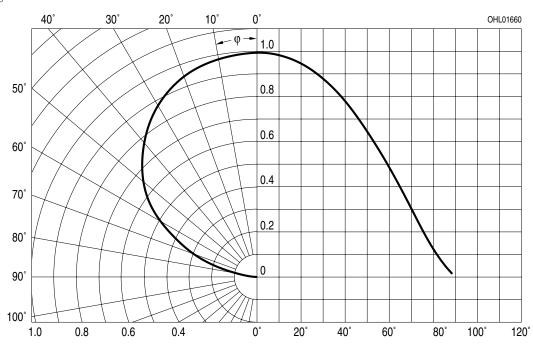
## Relative Spectral Emission 7)

$$I_{rel}$$
 = f ( $\lambda$ );  $I_F$  = 20 mA;  $T_S$  = 25 °C



### Radiation Characteristics 7)

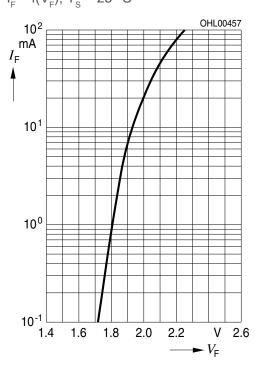
$$I_{rel} = f (\phi); T_S = 25 \, ^{\circ}C$$





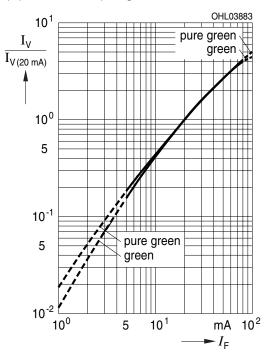
### Forward current 7), 8)

$$I_F = f(V_F); T_S = 25 \, ^{\circ}C$$



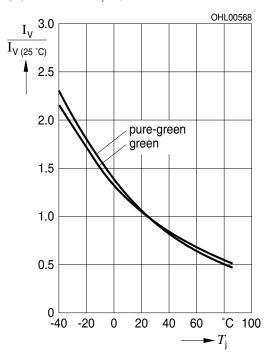
# Relative Luminous Intensity 7), 8)

$$I_{v}/I_{v}(20 \text{ mA}) = f(I_{F}); T_{S} = 25 \text{ °C}$$



# Relative Luminous Intensity 7)

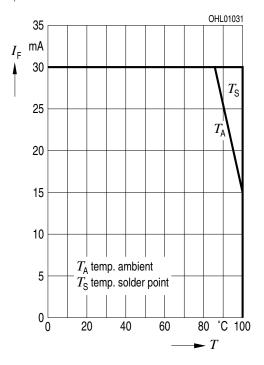
 $I_{v}/I_{v}(25 \text{ °C}) = f(T_{j}); I_{F} = 20 \text{ mA}$ 





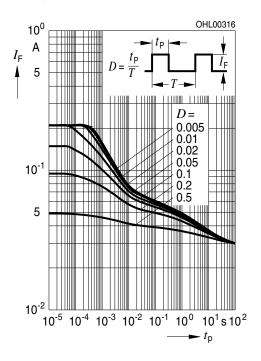
### Max. Permissible Forward Current

$$I_{\scriptscriptstyle F} = f(T)$$



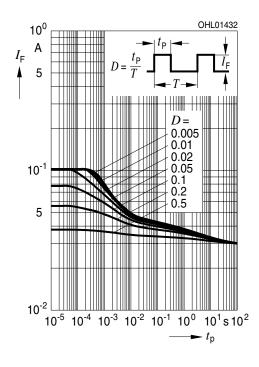
## Permissible Pulse Handling Capability

 $I_F = f(t_p)$ ; D: Duty cycle;  $T_S = 25 \, ^{\circ}C$ 

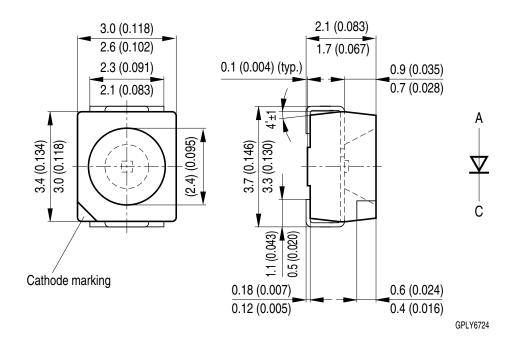


### **Permissible Pulse Handling Capability**

 $I_{_{\rm F}}$  = f(t $_{_{
m D}}$ ); D: Duty cycle;  $T_{_{
m S}}$  = 85 °C



# **Dimensional Drawing** 9)



**Approximate Weight:** 34.0 mg **Package marking:** Cathode

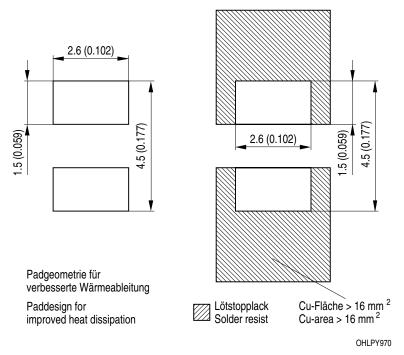
Corrosion test: Class: 3B

Test condition:  $40^{\circ}$ C / 90 % RH / 15 ppm H<sub>2</sub>S / 14 days (stricter then IEC

60068-2-43)

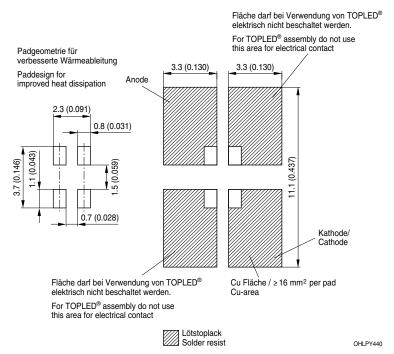


### Recommended Solder Pad 9)



For superior solder joint connectivity results we recommend soldering under standard nitrogen atmosphere. Package not suitable for ultra sonic cleaning.

#### Recommended Solder Pad 9)

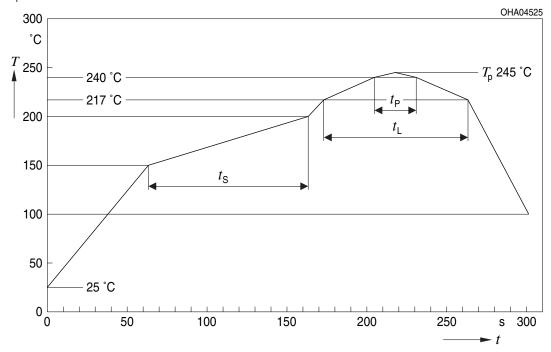


For superior solder joint connectivity results we recommend soldering under standard nitrogen atmosphere. Package not suitable for ultra sonic cleaning.



## **Reflow Soldering Profile**

Product complies to MSL Level 2 acc. to JEDEC J-STD-020E

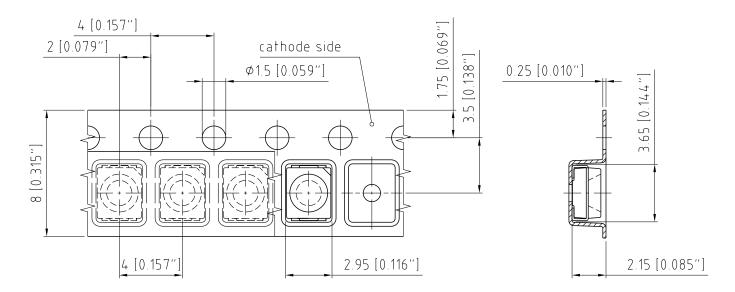


Profile Feature	Symbol	Pb	Pb-Free (SnAgCu) Assembly		
		Minimum	Recommendation	Maximum	
Ramp-up rate to preheat*) 25 °C to 150 °C			2	3	K/s
Time $t_s$ $T_{Smin}$ to $T_{Smax}$	t <sub>s</sub>	60	100	120	S
Ramp-up rate to peak*) $T_{\text{Smax}}$ to $T_{\text{P}}$			2	3	K/s
Liquidus temperature	$T_L$		217		°C
Time above liquidus temperature	$t_{\scriptscriptstyle \perp}$		80	100	S
Peak temperature	T <sub>P</sub>		245	260	°C
Time within 5 °C of the specified peak temperature T <sub>p</sub> - 5 K	t <sub>P</sub>	10	20	30	S
Ramp-down rate* T <sub>P</sub> to 100 °C			3	6	K/s
Time 25 °C to T <sub>P</sub>				480	S

All temperatures refer to the center of the package, measured on the top of the component  $^{\star}$  slope calculation DT/Dt: Dt max. 5 s; fulfillment for the whole T-range



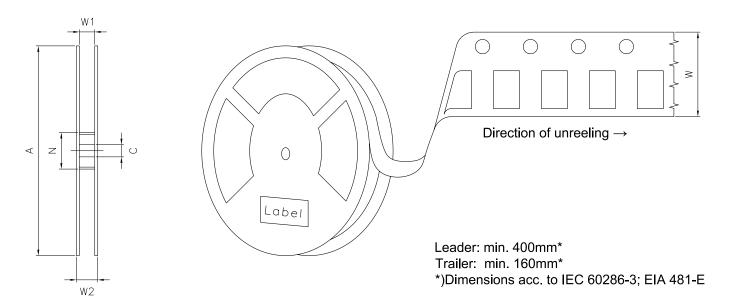
# Taping 9)



C63062-A1844-B3-04



## Tape and Reel 10)



# Reel dimensions [mm]

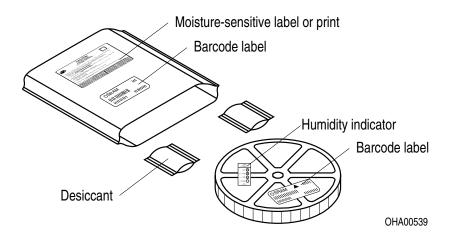
Α	W	$N_{\min}$	$W_1$	$W_{2\text{max}}$	Pieces per PU
180 mm	8 + 0.3 / - 0.1	60	8.4 + 2	14.4	2000
330 mm	8 + 0.3 / - 0.1	60	8.4 + 2	14.4	8000



# **Barcode-Product-Label (BPL)**



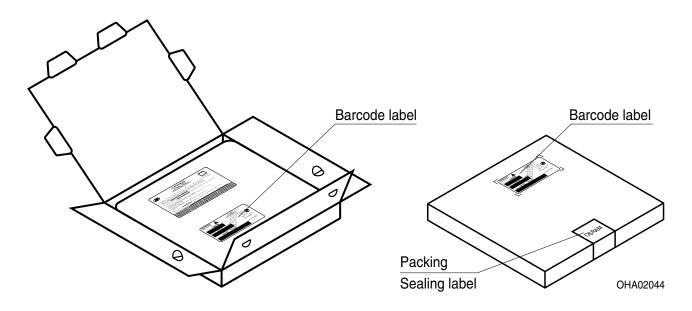
## **Dry Packing Process and Materials** 9)



Moisture-sensitive product is packed in a dry bag containing desiccant and a humidity card according JEDEC-STD-033.



# Transportation Packing and Materials 9)



# Dimensions of transportation box in mm

Width	Length	Height		
200 ± 5 mm	195 ± 5 mm	30 ± 5 mm		
352 ± 5 mm	352 ± 5 mm	33 ± 5 mm		



## **Type Designation System**

Wavelength (λ <sub>dom</sub> typ.)		Em	ission Col	or		coordina 931/Emis		according		
A: S: T: Y: O: G: P:	61 633 528 58 600 570 560	7 nm 3 nm 3 nm 7 nm 6 nm 0 nm	sup true yell ora gre pur	nge en e green	_	W: UW: CB: CG: CL:	white ultra whit color on o color on o	e dem dem dem	and blue and green and lagune	
R: B: H: V:	470 645 509	5 nm 0 nm 5 nm 5 nm					/ Packa T:		PLED	
L:		ht nitting / nde	/			/				
	L	,	A			т	6		7	6
	Lead 6: 7: T: V:	folded revers folded Au-LF folded	leads e gullv leads, ), w/o leads	operties ving leads improved of TiO2 jetting and UX:3 w bility (Au-LF	/ im	proved				
		Enca 7: S:	Color (resin	nt Type / Le less clear of encapsulatine (with or v	r wh	ite volu	me conve	ersio /	n	
		1: T 3: st 4: A 5: H 6: S 9: T B: H C: A D: L G: T G: T K: Ir	SN andard IGaAs OP 20 tandar SN low OP 20 TON DW cos hinfilm hinGal GaAlF andard	d InGalP v current	nGal t	N) (Sub	,	phire/		



#### **Notes**

The evaluation of eye safety occurs according to the standard IEC 62471:2006 (photo biological safety of lamps and lamp systems). Within the risk grouping system of this IEC standard, the LED specified in this data sheet fall into the class exempt group (exposure time 10000 s). Under real circumstances (for exposure time, eye pupils, observation distance), it is assumed that no endangerment to the eye exists from these devices. As a matter of principle, however, it should be mentioned that intense light sources have a high secondary exposure potential due to their blinding effect. As is also true when viewing other bright light sources (e.g. headlights), temporary reduction in visual acuity and afterimages can occur, leading to irritation, annoyance, visual impairment, and even accidents, depending on the situation.

Subcomponents of this LED contain, in addition to other substances, metal filled materials including silver. Metal filled materials can be affected by environments that contain traces of aggressive substances. Therefore, we recommend that customers minimize LED exposure to aggressive substances during storage, production, and use. LEDs that showed visible discoloration when tested using the described tests above did show no performance deviations within failure limits during the stated test duration. Respective failure limits are described in the IEC60810.

For further application related informations please visit www.osram-os.com/appnotes



#### **Disclaimer**

#### Disclaimer

Language english will prevail in case of any discrepancies or deviations between the two language wordings.

#### Attention please!

The information describes the type of component and shall not be considered as assured characteristics. Terms of delivery and rights to change design reserved. Due to technical requirements components may contain dangerous substances.

For information on the types in question please contact our Sales Organization.

If printed or downloaded, please find the latest version on the OSRAM OS webside.

#### **Packing**

Please use the recycling operators known to you. We can also help you – get in touch with your nearest sales office.

By agreement we will take packing material back, if it is sorted. You must bear the costs of transport. For packing material that is returned to us unsorted or which we are not obliged to accept, we shall have to invoice you for any costs incurred.

#### Product safety devices/applications or medical devices/applications

OSRAM OS components are not developed, constructed or tested for the application as safety relevant component or for the application in medical devices.

In case Buyer – or Customer supplied by Buyer– considers using OSRAM OS components in product safety devices/applications or medical devices/applications, Buyer and/or Customer has to inform the local sales partner of OSRAM OS immediately and OSRAM OS and Buyer and /or Customer will analyze and coordinate the customer-specific request between OSRAM OS and Buyer and/or Customer.



#### Glossary

- Brightness: Brightness values are measured during a current pulse of typically 25 ms, with an internal reproducibility of  $\pm 8$  % and an expanded uncertainty of  $\pm 11$  % (acc. to GUM with a coverage factor of k = 3).
- Reverse Operation: Reverse Operation of 10 hours is permissible in total. Continuous reverse operation is not allowed.
- Wavelength: The wavelength is measured at a current pulse of typically 25 ms, with an internal reproducibility of ±0.5 nm and an expanded uncertainty of ±1 nm (acc. to GUM with a coverage factor of k = 3).
- Forward Voltage: The forward voltage is measured during a current pulse of typically 8 ms, with an internal reproducibility of  $\pm 0.05$  V and an expanded uncertainty of  $\pm 0.1$  V (acc. to GUM with a coverage factor of k = 3).
- <sup>5)</sup> **Thermal Resistance**: Rth max is based on statistic values (6σ).
- Thermal Resistance: RthJA results from mounting on PC board FR 4 (pad size 16 mm² per pad)
- Typical Values: Due to the special conditions of the manufacturing processes of LED, the typical data or calculated correlations of technical parameters can only reflect statistical figures. These do not necessarily correspond to the actual parameters of each single product, which could differ from the typical data and calculated correlations or the typical characteristic line. If requested, e.g. because of technical improvements, these typ. data will be changed without any further notice.
- <sup>8)</sup> Characteristic curve: In the range where the line of the graph is broken, you must expect higher differences between single LEDs within one packing unit.
- Tolerance of Measure: Unless otherwise noted in drawing, tolerances are specified with ±0.1 and dimensions are specified in mm.
- <sup>10)</sup> **Tape and Reel**: All dimensions and tolerances are specified acc. IEC 60286-3 and specified in mm.



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